2SD1262, 2SD1262A

Silicon NPN triple diffusion planar type darlington

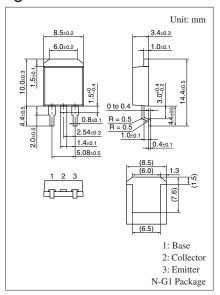
For midium speed power switching Complementary to 2SB0939, 2SB0939A

Features

- \bullet High forward current transfer ratio h_{FE}
- High-speed switching
- N type package enabling direct soldering of the radiating fin to the printed circuit board, etc. of small electronic equipment.

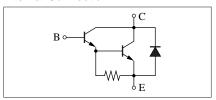
■ Absolute Maximum Ratings $T_C = 25$ °C

Parameter	Symbol	Rating	Unit	
Collector-base voltage	2SD1262	V _{CBO}	60	V
(Emitter open)	2SD1262A		80	
Collector-emitter voltage	2SD1262	V _{CEO}	60	V
(Base open)	2SD1262A		80	
Emitter-base voltage (Coll	V_{EBO}	7	V	
Collector current	I_C	8	A	
Peak collector current	I_{CP}	12	A	
Collector power dissipation		P _C	45	W
	$T_a = 25^{\circ}C$		1.3	
Junction temperature		T _j	150	°C
Storage temperature		T_{stg}	-55 to +150	°C



Note) Self-supported type package is also prepared.

Internal Connection



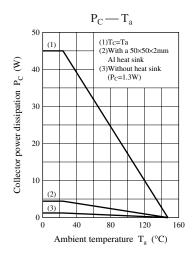
■ Electrical Characteristics $T_C = 25$ °C ± 3 °C

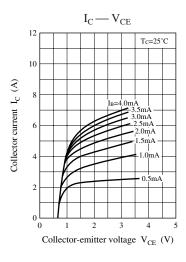
Parameter		Symbol	Conditions	Min	Тур	Max	Unit
Collector-emitter voltage	2SD1262	V _{CEO}	$I_C = 30 \text{ mA}, I_B = 0$	60			V
(Base open)	2SD1262A			80			
Collector-base cutoff	2SD1262	I_{CBO}	$V_{CB} = 60 \text{ V}, I_{E} = 0$			100	μΑ
current (Emitter open)	2SD1262A		$V_{CB} = 80 \text{ V}, I_{E} = 0$			100	
Emitter-base cutoff current (Collector open)		I_{EBO}	$V_{EB} = 7 \text{ V}, I_{C} = 0$			2	mA
Forward current transfer ratio		h _{FE1} *	$V_{CE} = 3 \text{ V}, I_{C} = 4 \text{ A}$	1 000		10 000	_
		h _{FE2}	$V_{CE} = 3 \text{ V}, I_{C} = 8 \text{ A}$	500			
Collector-emitter saturation voltage		V _{CE(sat)}	$I_C = 4 \text{ A}, I_B = 8 \text{ mA}$			1.5	V
Base-emitter saturation voltage		V _{BE(sat)}	$I_C = 4 \text{ A}, I_B = 8 \text{ mA}$			2.0	V
Transition frequency		f_T	$V_{CE} = 10 \text{ V}, I_{C} = 0.5 \text{ A}, f = 1 \text{ MHz}$		20		MHz
Turn-on time		t _{on}	I _C = 4 A		0.5		μs
Strage time		t _{stg}	$I_{B1} = 8 \text{ mA}, I_{B2} = -8 \text{ mA}$		4.0		μs
Fall time		$t_{\rm f}$	$V_{CC} = 50 \text{ V}$		1.0		μs

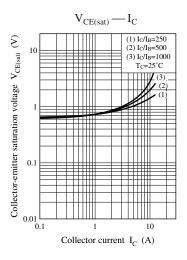
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

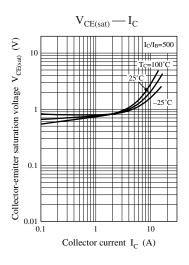
2. *: Rank classification

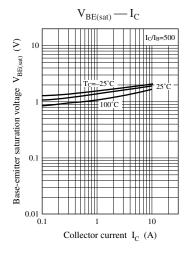
Rank	R	Q	Р
h_{FE1}	1000 to 2500	2000 to 5000	4000 to 10000

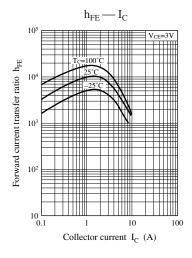


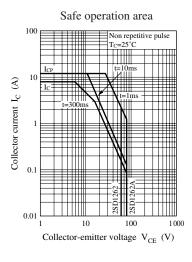


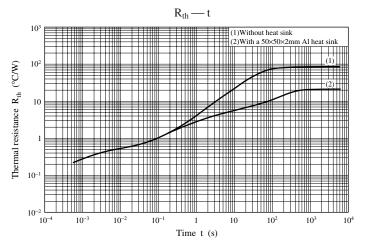












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